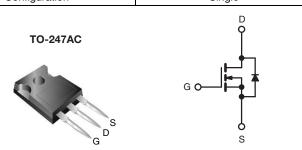


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	V <sub>DS</sub> (V) 500				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 0.135				
Q <sub>g</sub> (Max.) (nC)	190				
Q <sub>gs</sub> (nC)	59				
Q <sub>gd</sub> (nC)	84				
Configuration	Single				



#### **FEATURES**

ullet Low Gate Charge  $\mathbf{Q}_{\mathbf{g}}$  Results in Simple Drive Requirement



• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low R<sub>DS(on)</sub>
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switching and High Frequency Circuits

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP32N50KPbF		
Leau (FD)-liee	SiHFP32N50K-E3		
SnPb	IRFP32N50K		
SHED	SiHFP32N50K		

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	500	.,	
Gate-Source Voltage			V <sub>GS</sub>	± 30	- V	
Continuous Drain Current	V at 10 V	T <sub>C</sub> = 25 °C		32		
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	ID	20	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	130	1	
Linear Derating Factor				3.7	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	450	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	32	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	46	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			P <sub>D</sub>	460	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	13	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	00	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>	°C	
Mauring Tayous	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. Starting  $T_J$  = 25 °C, L = 0.87 mH,  $R_q$  = 25  $\Omega$ ,  $I_{AS}$  = 32 A.
- c.  $I_{SD} \le 32$  A,  $dI/dt \le 197$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP32N50K, SiHFP32N50K

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THERMAL RESISTANCE RATINGS					
PARAMETER	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	$R_{thJA}$	-	40		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.26		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		<u> </u>					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0 V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I <sub>D</sub> = 1 mA	-	0.54	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30 V	=.	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	50	
zero Gate voltage Drain Current		V <sub>DS</sub> = 400 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 32 A <sup>b</sup>	-	0.135	0.16	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub>	= 50 V, I <sub>D</sub> = 32 A	14	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$	-	5280	-	_
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 25 \text{ V},$	-	550	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	.0 MHz, see fig. 5	-	45	-	nE
Output Capacitance	C <sub>oss</sub>		V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	ī	5630	-	pF
Output Capacitance		$V_{GS} = 0 V$	V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	155	-	
Effective Output Capacitance	C <sub>oss</sub> eff.	V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>		-	265	-	
Total Gate Charge	$Q_g$			=.	-	190	
Gate-Source Charge	$Q_{gs}$	$V_{GS} = 10 \text{ V}$ $I_D = 32 \text{ A}, V_{DS} = 400 \text{ V}^b$		-	-	59	nC
Gate-Drain Charge	$Q_{gd}$			-	-	84	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 250 V, $I_{D}$ = 32 A, Rg = 4.3 $\Omega$ , $V_{GS}$ = 10 V <sup>b</sup>		-	28	-	
Rise Time	t <sub>r</sub>			-	120	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	48	-	
Fall Time	t <sub>f</sub>			-	54	-	
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		1	1	32	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			1	-	130	_ ^
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 32  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 32 A, dl/dt = 100 A/μs <sup>b</sup>		-	530	800	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	9.0	13.5	μC
Body Diode Reverse Recovery Current	I <sub>RRM</sub>			-	30	-	Α
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )				1.5)	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. Pulse width  $\leq 400~\mu s;$  duty cycle  $\leq 2~\%.$
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

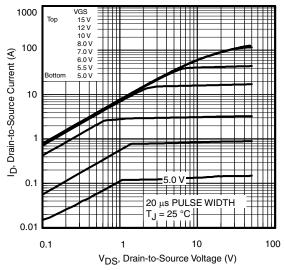


Fig. 1 - Typical Output Characteristics

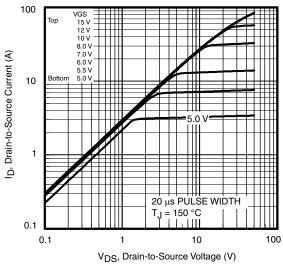


Fig. 2 - Typical Output Characteristics

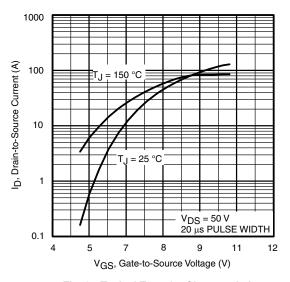


Fig. 3 - Typical Transfer Characteristics

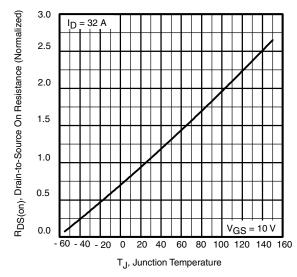


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFP32N50K, SiHFP32N50K

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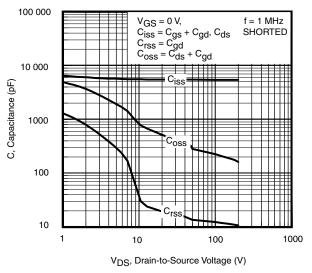


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

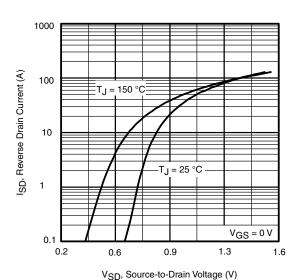


Fig. 7 - Typical Source-Drain Diode Forward Voltage

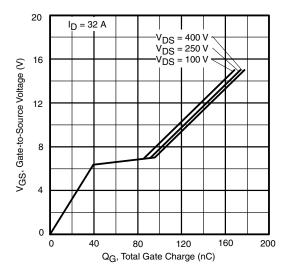


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

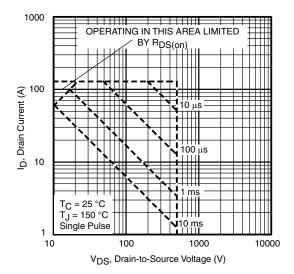


Fig. 8 - Maximum Safe Operating Area



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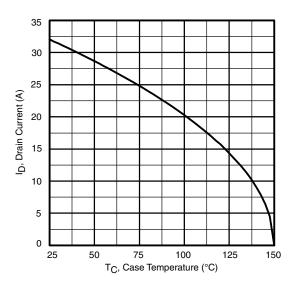


Fig. 9 - Maximum Drain Current vs. Case Temperature

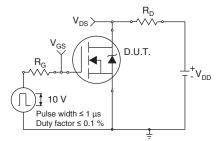


Fig. 10a - Switching Time Test Circuit

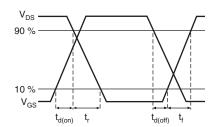


Fig. 10b - Switching Time Waveforms

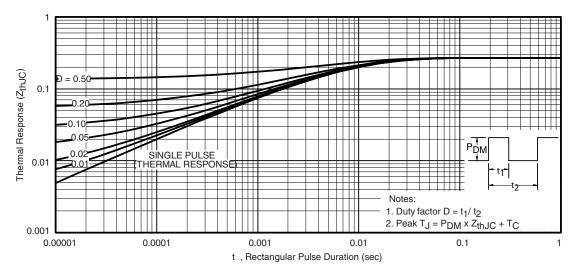


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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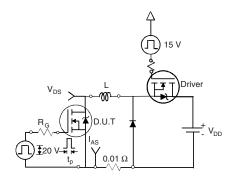


Fig. 12a - Unclamped Inductive Test Circuit

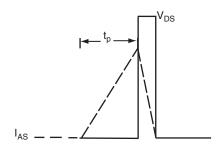


Fig. 12b - Unclamped Inductive Waveforms

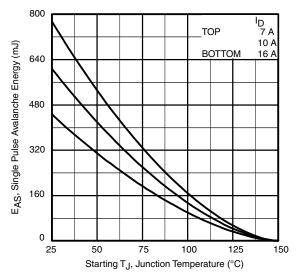


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

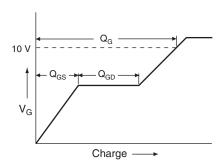


Fig. 13a - Basic Gate Charge Waveform

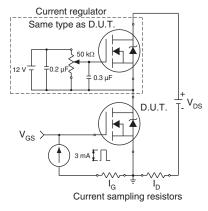
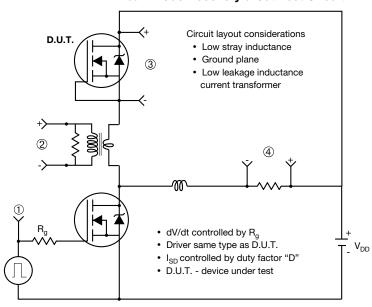


Fig. 13b - Gate Charge Test Circuit

#### Peak Diode Recovery dV/dt Test Circuit



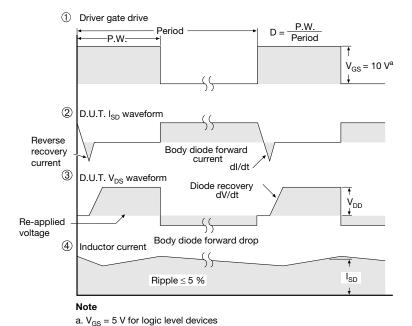
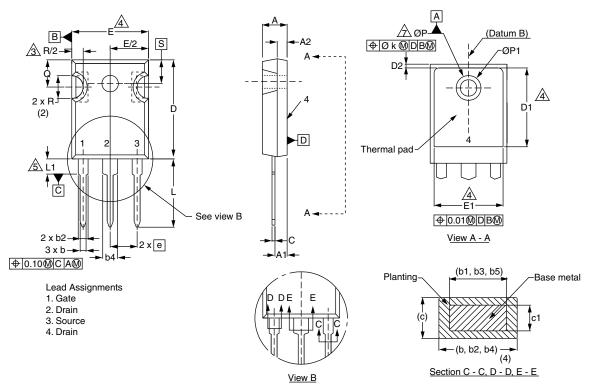


Fig. 14 - For N-Channel

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## **TO-247AC (High Voltage)**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	1

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
E	15.29	15.87	0.602	0.625	
E1	13.72	ı	0.540	ı	
е	5.46	BSC	0.215	0.215 BSC	
Øk	0.254		0.010		
L	14.20	16.25	0.559	0.640	
L1	3.71	4.29	0.146	0.169	
N	7.62	7.62 BSC		0.300 BSC	
ØΡ	3.51	3.66	0.138	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217	BSC	

ECN: X13-0103-Rev. D, 01-Jul-13 DWG: 5971

### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.



Revision: 01-Jul-13 Document Number: 91360



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